

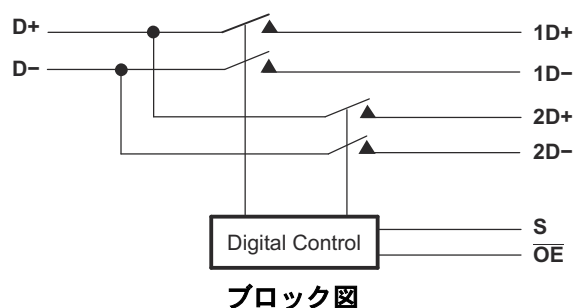
TS3USB221 シングル イネーブル付きの High-Speed USB 2.0 (480Mbps) 1:2 マルチプレクサ/デマルチプレクサ スイッチ

1 特長

- 2.3V および 3.6V の V_{CC} で動作
- V_{IO} は最大 5.5V の信号に対応
- 1.8V 互換の制御ピン入力
- $\overline{OE}$ がディセーブルのとき低消費電力モード (1 μ A)
- $R_{ON} = 6\Omega$ (最大値)
- $\Delta r_{ON} = 0.2\Omega$ (標準値)
- $C_{IO(ON)} = 6\text{pf}$ (最大値)
- 低消費電力 (最大 30 μ A)
- 人体モデル (HBM) で 2000V 超の ESD
- 高帯域幅: 1GHz (標準値)

2 アプリケーション

- USB 1.0、1.1、2.0 の信号ルーティング
- モバイル産業用プロセッサ インターフェイス (MIPI™) の信号配線
- MHL 1.0



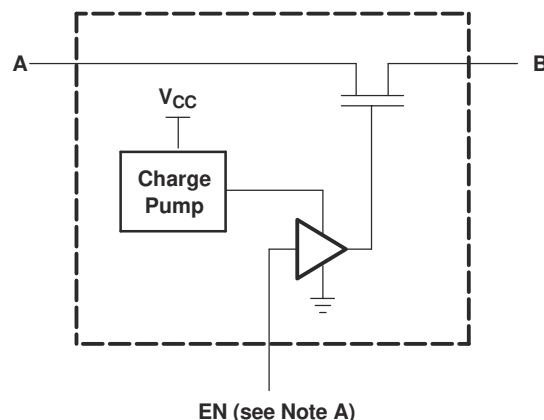
3 概要

TS3USB221 は、USB I/O 数が限られたハブまたはコントローラを備えたハンドセットおよび民生アプリケーション (例: 携帯電話、デジタル カメラ、ノート PC) での High-Speed USB 2.0 信号のスイッチングに特化して設計された高帯域幅スイッチです。このスイッチは帯域幅が広く (1GHz)、エッジと位相の歪みを最小限に抑えて信号を通過させることができます。このデバイスは、USB ホスト デバイスからの差動出力を、対応する 2 つの出力のどちらかに多重化します。このスイッチは双方向であり、出力での高速信号の減衰は全くないか、あってもわずかです。TS3USB221 は、ビット間のスキューが小さく、チャンネル間のノイズ分離が大きくなるよう設計されています。また、TS3USB221 は High-Speed USB 2.0 (480Mbps) などの各種規格に適合しています。

パッケージ情報

部品番号	パッケージ ⁽¹⁾	パッケージ サイズ ⁽²⁾
TS3USB221	DRC (VSON, 10)	3mm × 3mm
	RSE (UQFN, 10)	2mm × 1.5mm

- (1) 供給されているすべてのパッケージについては、[セクション 11](#) を参照してください。
- (2) パッケージ サイズ (長さ × 幅) は公称値であり、該当する場合はピンも含まれます。



A. EN はスイッチに印加される内部イネーブル信号

概略回路図、各 FET スイッチ (SW)



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4 Pin Configuration and Functions

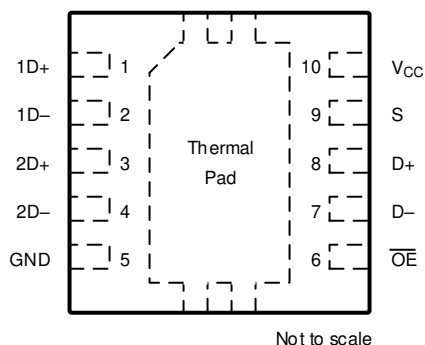


図 4-1. DRC Package, 10-Pin VSON (Top View)

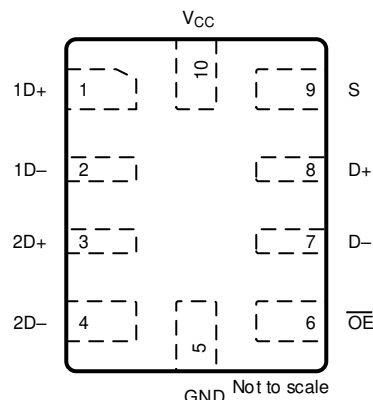


図 4-2. RSE Package, 10-Pin UQFN (Top View)

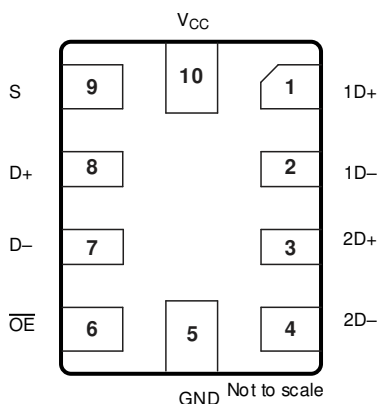


図 4-3. RSE Package, 10-Pin UQFB (Bottom View)

表 4-1. Pin Functions

PIN		TYPE ⁽¹⁾	DESCRIPTION
NAME	NO.		
1D+	1	I/O	USB port 1
1D-	2	I/O	
2D+	3	I/O	USB port 2
2D-	4	I/O	
GND	5	—	Ground
OE	6	I	Bus-switch enable
D-	7	I/O	Common USB port
D+	8	I/O	
S	9	I	Select input
V _{CC}	10	—	Supply voltage

(1) I = input, O = output

5 Specifications

5.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)⁽¹⁾

			MIN	MAX	UNIT
V _{CC}	Supply voltage		−0.5	4.6	V
V _{IN}	Control input voltage ^{(2) (3)}		−0.5	7	V
V _{I/O}	Switch I/O voltage ^{(2) (3) (4) (6)}		−0.5	7	V
I _{IK}	Control input clamp current	V _{IN} < 0		−50	mA
I _{I/OK}	I/O port clamp current	V _{I/O} < 0		−50	mA
I _{I/O}	ON-state switch current ⁽⁵⁾			±120	mA
	Continuous current through V _{CC} or GND			±100	mA
T _{stg}	Storage temperature		−65	150	°C

- (1) Operation outside the *Absolute Maximum Ratings* may cause permanent device damage. *Absolute Maximum Ratings* do not imply functional operation of the device at these or any other conditions beyond those listed under *Recommended Operating Conditions*. If used outside the *Recommended Operating Conditions* but within the *Absolute Maximum Ratings*, the device may not be fully functional, and this may affect device reliability, functionality, performance, and shorten the device lifetime.
- (2) All voltages are with respect to ground, unless otherwise specified.
- (3) The input and output voltage ratings may be exceeded if the input and output clamp-current ratings are observed.
- (4) V_I and V_O are used to denote specific conditions for V_{I/O}.
- (5) I_I and I_O are used to denote specific conditions for I_{I/O}.
- (6) The I/O pins are 5.5V tolerant and functional for the entire range. However, for V_{I/O} > 3.6V, the channel RON is high (up to 100Ω).

5.2 ESD Ratings

			VALUE	UNIT
V _(ESD)	Electrostatic discharge	Human-body model (HBM), per ANSI/ESDA/JEDEC JS-001 ⁽¹⁾	±2000	V
		Charged-device model (CDM), per ANSI/ESDA/JEDEC JS-002 ⁽²⁾	±1500	V

- (1) JEDEC document JEP155 states that 500V HBM allows safe manufacturing with a standard ESD control process.
- (2) JEDEC document JEP157 states that 250V CDM allows safe manufacturing with a standard ESD control process.

5.3 Recommended Operating Conditions

See ⁽¹⁾.

			MIN	MAX	UNIT
V _{CC}	Supply voltage		2.3	3.6	V
V _{IH}	High-level control input voltage	V _{CC} = 2.3V to 2.7V	0.46 × V _{CC}	V _{CC}	V
		V _{CC} = 2.7V to 3.6V			
V _{IL}	Low-level control input voltage	V _{CC} = 2.3V to 2.7V	0	0.25 × V _{CC}	V
		V _{CC} = 2.7V to 3.6V			
V _{I/O}	Data input/output voltage		0	5.5	V
T _A	Operating free-air temperature		−40	85	°C

- (1) All unused control inputs of the device must be held at V_{CC} or GND to ensure proper device operation. Refer to the *Implications of Slow or Floating CMOS Inputs* application note.

5.4 Thermal Information

THERMAL METRIC ⁽¹⁾		TS3USB221		UNIT
		DRC (VSON)	RSE (UQFN)	
		10 PINS	10 PINS	
R _{θJA}	Junction-to-ambient thermal resistance	57.7	204.8	°C/W
R _{θJC(top)}	Junction-to-case (top) thermal resistance	87.7	118.1	
R _{θJB}	Junction-to-board thermal resistance	32.6	121.5	
ψ _{JT}	Junction-to-top characterization parameter	8.2	13.9	
ψ _{JB}	Junction-to-board characterization parameter	32.8	121.2	
R _{θJC(bot)}	Junction-to-case (bottom) thermal resistance	18.5	N/A	

(1) For more information about traditional and new thermal metrics, see the [Semiconductor and IC Package Thermal Metrics](#) application note.

5.5 Electrical Characteristics

over operating free-air temperature range (unless otherwise noted)⁽¹⁾

PARAMETER	TEST CONDITIONS		MIN	TYP ⁽²⁾	MAX	UNIT
V _{IK}	V _{CC} = 3.6V, 2.7V,	I _I = –18mA	–1.8			V
I _{IN} Control inputs	V _{CC} = 3.6V, 2.7V, 0V,	V _{IN} = 0V to 3.6V			±1	μA
I _{OZ} ⁽³⁾	V _{CC} = 3.6V, 2.7V, V _O = 0V to 3.6V, V _I = 0V,	V _{IN} = V _{CC} or GND, Switch OFF			±1	μA
I _{OFF}	V _{CC} = 0V	V _{I/O} = 0V to 3.6V			±2	μA
		V _{I/O} = 0V to 2.7V			±1	
I _{CC}	V _{CC} = 3.6V, 2.7V, V _{IN} = V _{CC} or GND,	I _{I/O} = 0V, Switch ON or OFF			30	μA
I _{CC} (low power mode)	V _{CC} = 3.6V, 2.7V, V _{IN} = V _{CC} or GND	Switch disabled ($\overline{\text{OE}}$ in high state)			1	μA
ΔI _{CC} ⁽⁴⁾ Control inputs	One input at 1.8V, Other inputs at V _{CC} or GND	V _{CC} = 3.6V			20	μA
		V _{CC} = 2.7V			0.5	
C _{in} Control inputs	V _{CC} = 3.3V, 2.5V,	V _{IN} = 3.3V or 0V		1	2	pF
C _{io(OFF)}	V _{CC} = 3.3V, 2.5V,	V _{I/O} = 3.3V or 0V, Switch OFF		3	4	pF
C _{io(ON)}	V _{CC} = 3.3V, 2.5V,	V _{I/O} = 3.3V or 0V, Switch ON		5	6	pF
r _{on} ⁽⁵⁾	V _{CC} = 3V, 2.3V	V _I = 0V, I _O = 30mA			6	Ω
		V _I = 2.4V, I _O = –15mA			6	
Δr _{on}	V _{CC} = 3V, 2.3V	V _I = 0V, I _O = 30mA		0.2		Ω
		V _I = 1.7, I _O = –15mA		0.2		
r _{on(flat)}	V _{CC} = 3V, 2.3V	V _I = 0V, I _O = 30mA		1		Ω
		V _I = 1.7, I _O = –15mA		1		

(1) V_{IN} and I_{IN} refer to control inputs. V_I, V_O, I_I, and I_O refer to data pins.

(2) All typical values are at V_{CC} = 3.3V (unless otherwise noted), T_A = 25°C.

(3) For I/O ports, the parameter I_{OZ} includes the input leakage current.

(4) This is the increase in supply current for each input that is at the specified TTL voltage level, rather than V_{CC} or GND.

(5) Measured by the voltage drop between the A and B terminals at the indicated current through the switch. ON-state resistance is determined by the lower of the voltages of the two (A or B) terminals.

5.6 Dynamic Electrical Characteristics, $V_{CC} = 3.3V \pm 10\%$

over operating range, $T_A = -40^\circ\text{C}$ to 85°C , $V_{CC} = 3.3V \pm 10\%$, $GND = 0V$

PARAMETER		TEST CONDITIONS	TYP ⁽¹⁾	UNIT
X_{TALK}	Crosstalk	$R_L = 50\Omega$, $f = 250\text{MHz}$	-40	dB
O_{IRR}	OFF isolation	$R_L = 50\Omega$, $f = 250\text{MHz}$	-41	dB
BW	Bandwidth (-3dB)	$R_L = 50\Omega$	1	GHz

(1) For Maximum or Minimum conditions, use the appropriate value specified under [Electrical Characteristics](#) for the applicable device type.

5.7 Dynamic Electrical Characteristics, $V_{CC} = 2.5V \pm 10\%$

over operating range, $T_A = -40^\circ\text{C}$ to 85°C , $V_{CC} = 2.5V \pm 10\%$, $GND = 0V$

PARAMETER		TEST CONDITIONS	TYP ⁽¹⁾	UNIT
X_{TALK}	Crosstalk	$R_L = 50\Omega$, $f = 250\text{MHz}$	-39	dB
O_{IRR}	OFF isolation	$R_L = 50\Omega$, $f = 250\text{MHz}$	-40	dB
BW	Bandwidth (-3dB)	$R_L = 50\Omega$	1	GHz

(1) For maximum or minimum conditions, use the appropriate value specified under [Electrical Characteristics](#) for the applicable device type.

5.8 Switching Characteristics, $V_{CC} = 3.3V \pm 10\%$

over operating range, $T_A = -40^\circ\text{C}$ to 85°C , $V_{CC} = 3.3V \pm 10\%$, $GND = 0V$

PARAMETER		MIN	TYP ⁽¹⁾	MAX	UNIT
t_{pd}	Propagation delay ^{(2) (3)}		0.25		ns
t_{ON}	Line enable time	S to D, nD		30	ns
		$\overline{OE}$ to D, nD		17	
t_{OFF}	Line disable time	S to D, nD		12	ns
		$\overline{OE}$ to D, nD		10	
$t_{SK(O)}$	Output skew between center port to any other port ⁽²⁾		0.1	0.2	ns
$t_{SK(P)}$	Skew between opposite transitions of the same output ($t_{PHL} - t_{PLH}$) ⁽²⁾		0.1	0.2	ns

(1) For maximum or minimum conditions, use the appropriate value specified under [Electrical Characteristics](#) for the applicable device type.

(2) Specified by design

(3) The bus switch contributes no propagational delay other than the RC delay of the on resistance of the switch and the load capacitance. The time constant for the switch alone is of the order of 0.25ns for 10pF load. This time constant adds very little propagational delay to the system because the time is much smaller than the rise/fall times of typical driving signals. Propagational delay of the bus switch, when used in a system, is determined by the driving circuit on the driving side of the switch and the switch interactions with the load on the driven side.

5.9 Switching Characteristics, $V_{CC} = 2.5V \pm 10\%$

over operating range, $T_A = -40^\circ\text{C}$ to 85°C , $V_{CC} = 2.5V \pm 10\%$, $GND = 0V$

PARAMETER		MIN	TYP ⁽¹⁾	MAX	UNIT
t_{pd}	Propagation delay ^{(2) (3)}		0.25		ns
t_{ON}	Line enable time	S to D, nD		50	ns
		$\overline{OE}$ to D, nD		32	
t_{OFF}	Line disable time	S to D, nD		23	ns
		$\overline{OE}$ to D, nD		12	
$t_{SK(O)}$	Output skew between center port to any other port ⁽²⁾		0.1	0.2	ns
$t_{SK(P)}$	Skew between opposite transitions of the same output ($t_{PHL} - t_{PLH}$) ⁽²⁾		0.1	0.2	ns

(1) For maximum or minimum conditions, use the appropriate value specified under [Electrical Characteristics](#) for the applicable device type.

(2) Specified by design

- (3) The bus switch contributes no propagational delay other than the RC delay of the on resistance of the switch and the load capacitance. The time constant for the switch alone is of the order of 0.25ns for 10pF load. The time constraint adds very little propagational delay to the system because the time is much smaller than the rise and fall times of typical driving signals. Propagational delay of the bus switch, when used in a system, is determined by the driving circuit on the driving side of the switch and the switch interactions with the load on the driven side.

5.10 Typical Characteristics

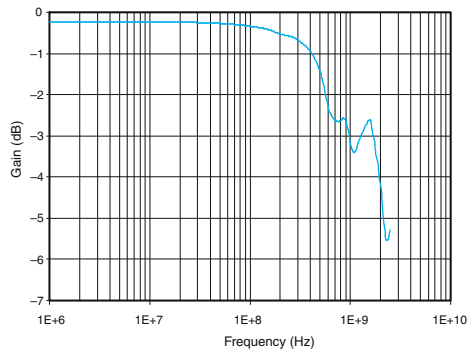


Figure 5-1. Gain vs Frequency

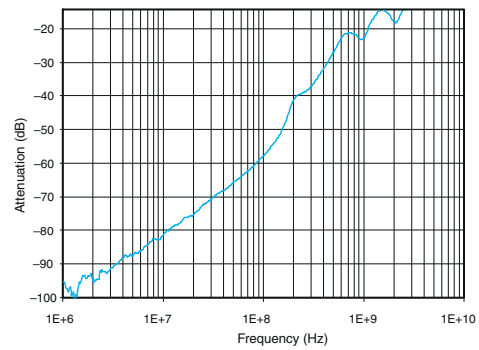


Figure 5-2. OFF Isolation vs Frequency

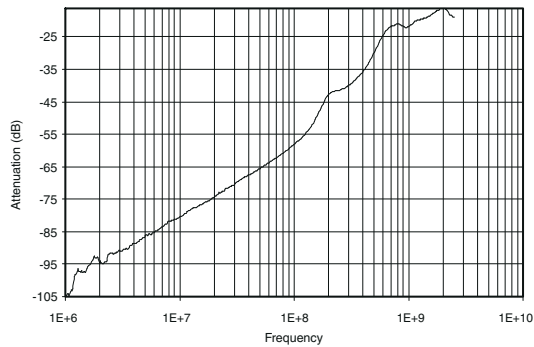


Figure 5-3. Crosstalk vs Frequency

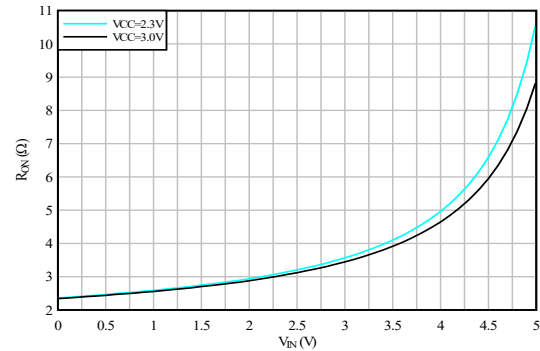
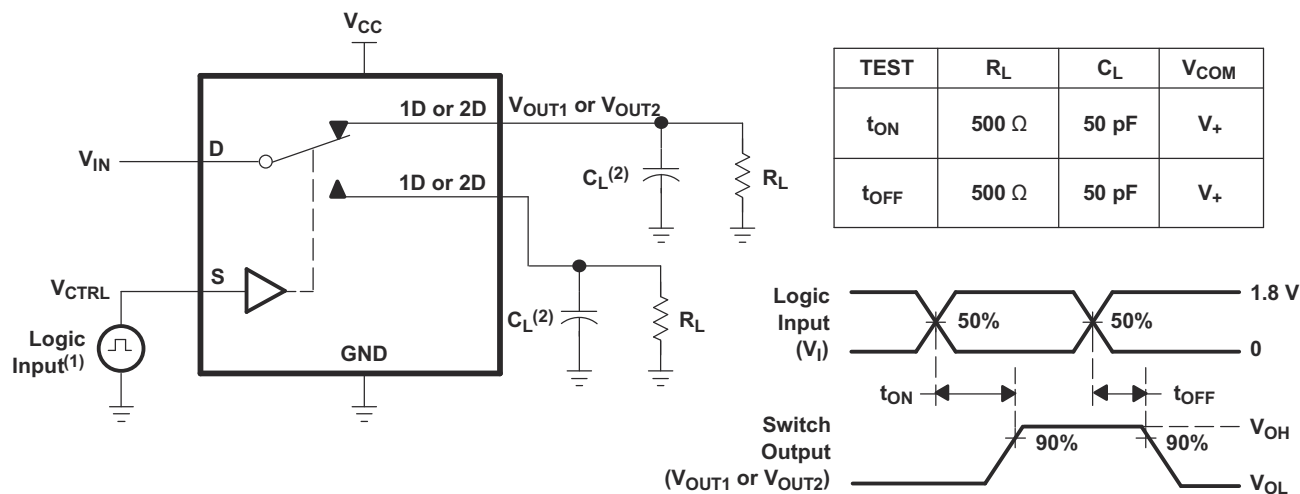


Figure 5-4. R_{on} vs V_{IN} ($I_{OUT} = -30$ mA)

6 Parameter Measurement Information



(1) All input pulses are supplied by generators having the following characteristics: PRR ≤ 10 MHz, Z_O = 50 Ω, t_r < 5 ns, t_f < 5 ns.

(2) C_L includes probe and jig capacitance.

图 6-1. Turnon (t_{ON}) and Turnoff Time (t_{OFF})

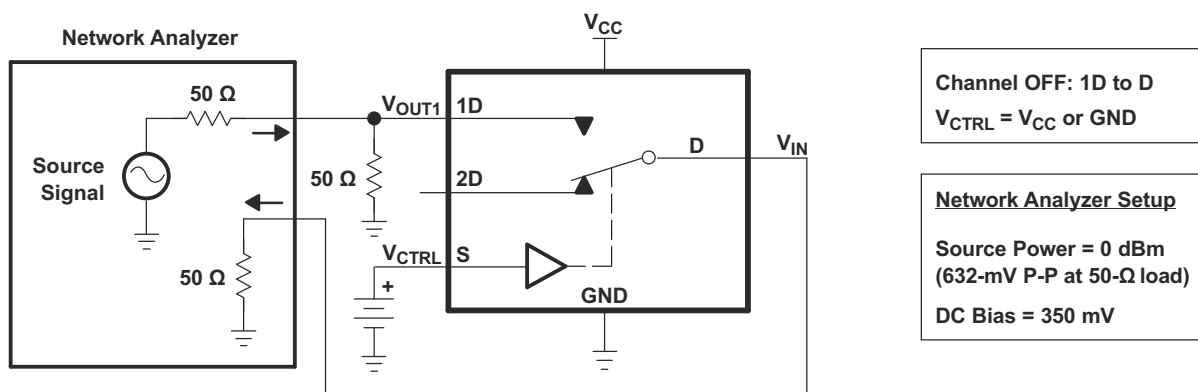


图 6-2. OFF Isolation (O_{ISO})

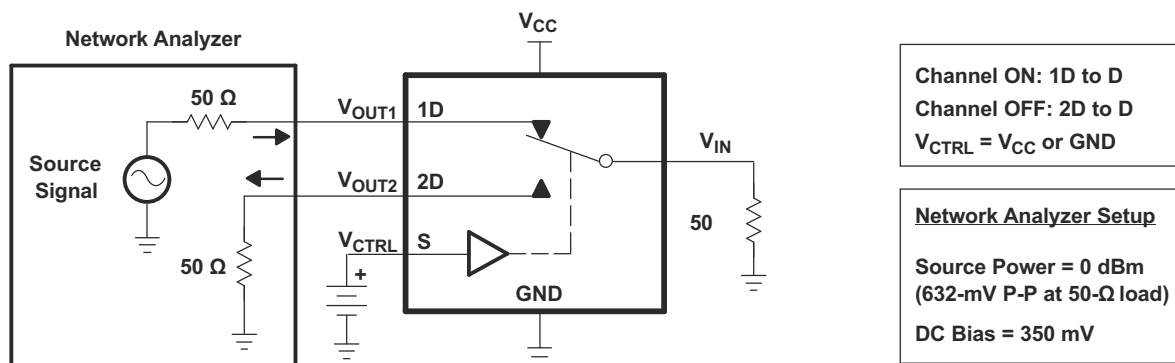


图 6-3. Crosstalk (X_{TALK})

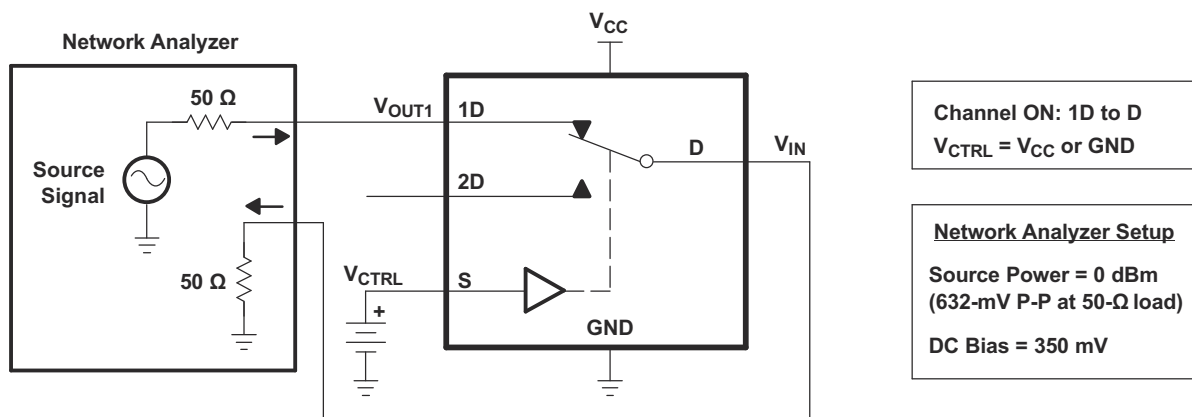


図 6-4. Bandwidth (BW)

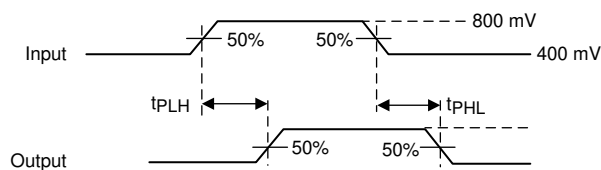
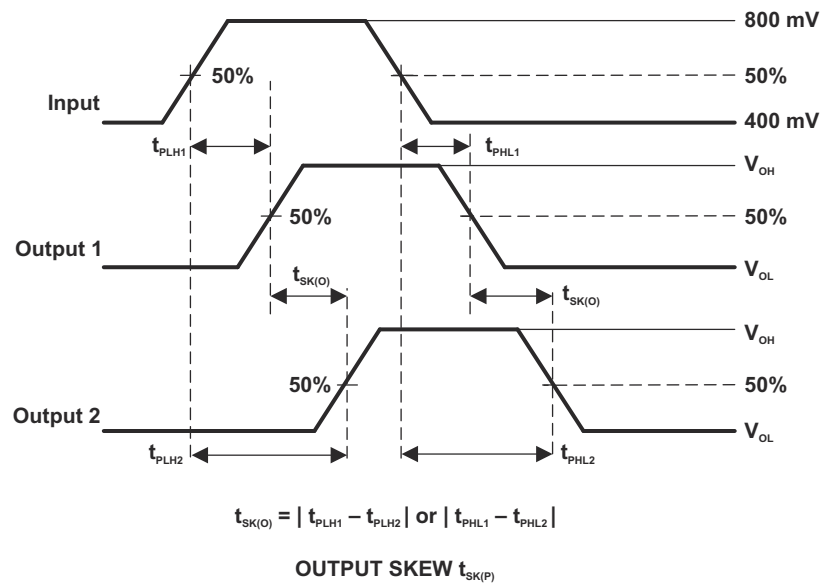
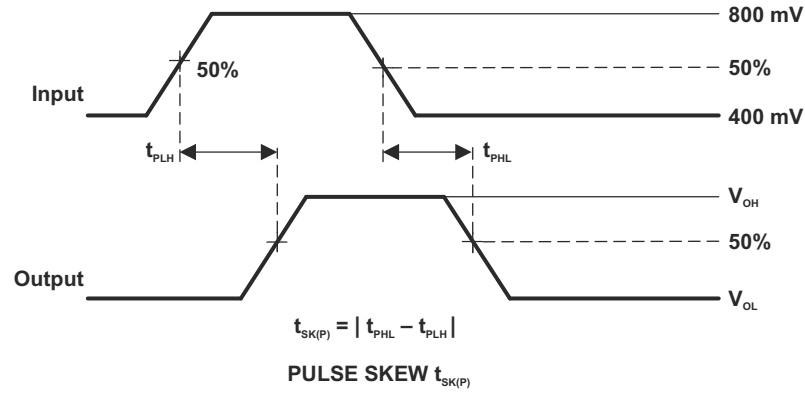
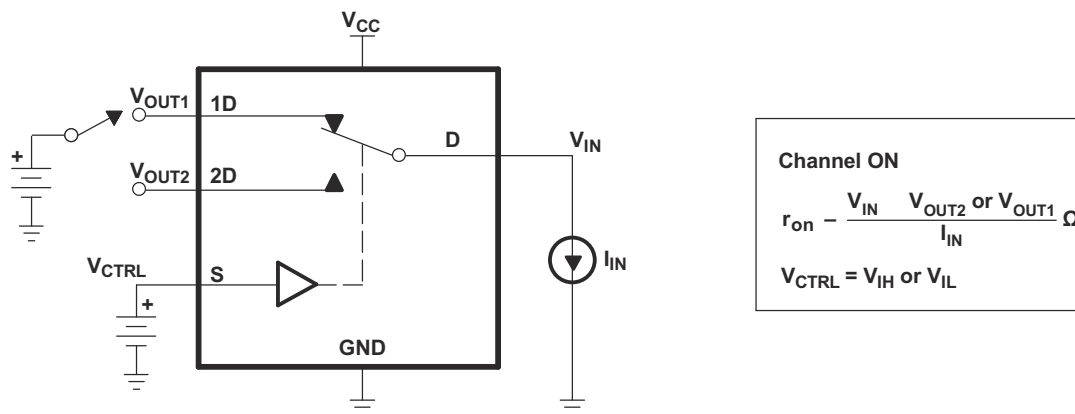
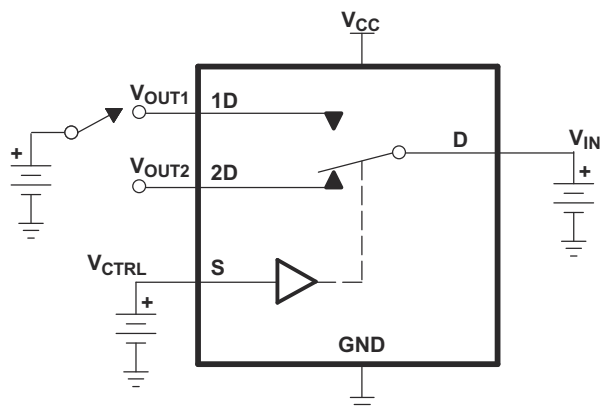


図 6-5. Propagation Delay



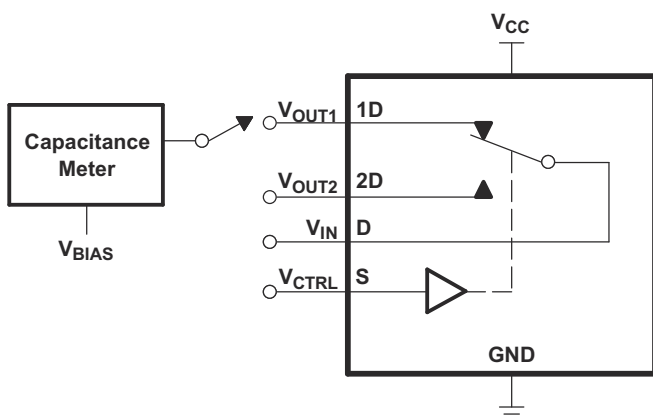
6-6. Skew Test


6-7. ON-State Resistance (r_{on})



OFF-State Leakage Current
Channel OFF
 $V_{CTRL} = V_{IH}$ or V_{IL}

図 6-8. OFF-State Leakage Current



$V_{BIAS} = V_{CC}$ or GND
 $V_{CTRL} = V_{CC}$ or GND
Capacitance is measured at 1D,
2D, D, and S inputs during ON
and OFF conditions.

図 6-9. Capacitance

7 Detailed Description

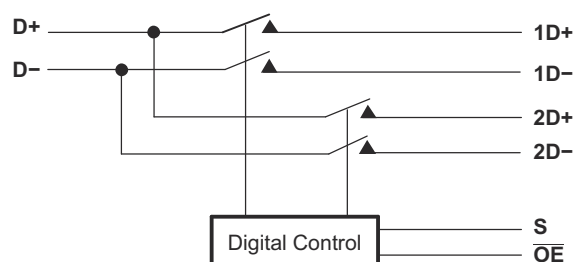
7.1 Overview

The TS3USB221 device is a 2-channel SPDT switch specially designed for the switching of high-speed USB 2.0 signals in handset and consumer applications, such as cell phones, digital cameras, and notebooks with hubs or controllers with limited USB I/Os. The wide bandwidth (1GHz) of this switch allows signals to pass with minimum edge and phase distortion. The device multiplexes differential outputs from a USB host device to one of two corresponding outputs. The switch is bidirectional and offers little or no attenuation of the high-speed signals at the outputs. The device also has a low power mode that reduces the power consumption to 1 μ A for portable applications with a battery or limited power budget.

The device is designed for low bit-to-bit skew and high channel-to-channel noise isolation, and is compatible with various standards, such as high-speed USB 2.0 (480Mbps).

The TS3USB221 device integrates ESD protection cells on all pins, is available in a SON package (3mm $\times$ 3mm) as well as in a tiny μ QFN package (2mm $\times$ 1.5mm) and is characterized over the free-air temperature range from -40°C to 85°C .

7.2 Functional Block Diagram



7.3 Feature Description

7.3.1 Low Power Mode

The TS3USB221 has a low power mode that reduces the power consumption to 1 μ A when the device is not in use. The bus-switch enable pin OE must be supplied with a logic high signal to put the device in low power mode and disable the switch.

7.4 Device Functional Modes

表 7-1. Truth Table

S	OE	FUNCTION
X	H	Disconnect
L	L	D = 1D
H	L	D = 2D

8 Application and Implementation

注

以下のアプリケーション情報は、TI の製品仕様に含まれるものではなく、TI ではその正確性または完全性を保証いたしません。個々の目的に対する製品の適合性については、お客様の責任で判断していただくことになります。お客様は自身の設計実装を検証しテストすることで、システムの機能を確認する必要があります。

8.1 Application Information

There are many USB applications in which the USB hubs or controllers have a limited number of USB I/Os. The TS3USB221 can effectively expand the limited USB I/Os by switching between multiple USB buses and interface with the buses on a single USB hub or controller. TS3USB221 can also be used to connect a single controller to two USB connectors.

8.2 Typical Application

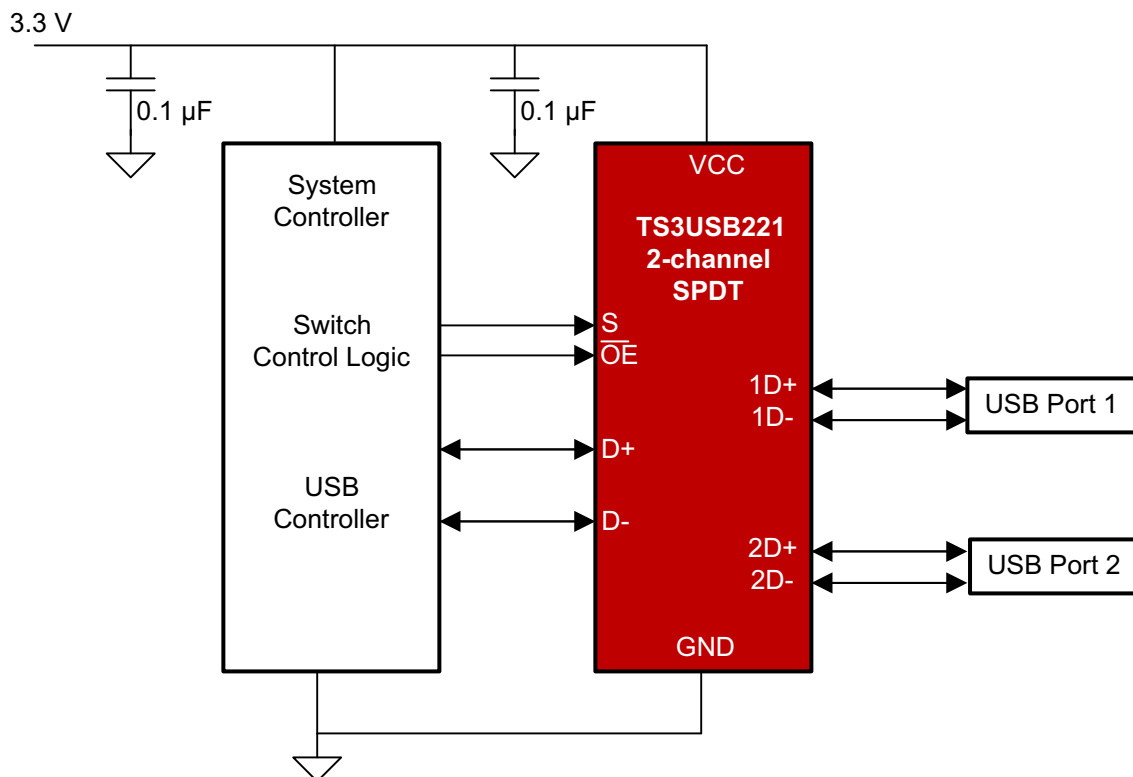


図 8-1. Simplified Schematic

8.2.1 Design Requirements

Follow the design requirements of the USB 1.0, 1.1, and 2.0 standards.

TI recommends that the digital control pins S and $\overline{OE}$ be pulled up to V_{CC} or down to GND to avoid undesired switch positions that can result from the floating pin.

8.2.2 Detailed Design Procedure

The TS3USB221 can operate properly without any external components. However, TI recommends to connect unused pins to ground through a 50Ω resistor to prevent signal reflections back into the device.

8.2.3 Application Curves

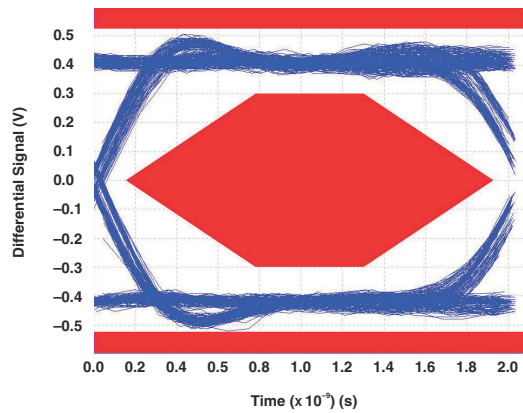


図 8-2. Eye Pattern: 480Mbps USB Signal With No Switch (Through Path)

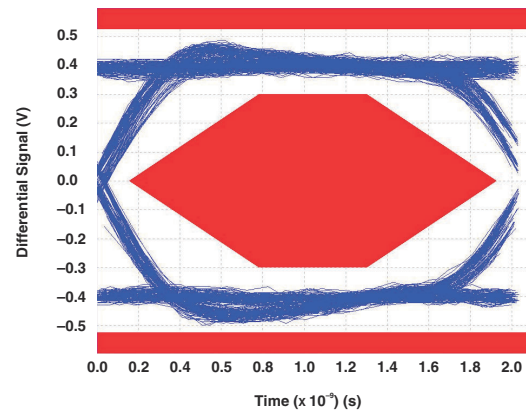


図 8-3. Eye Pattern: 480Mbps USB Signal With Switch NC Path

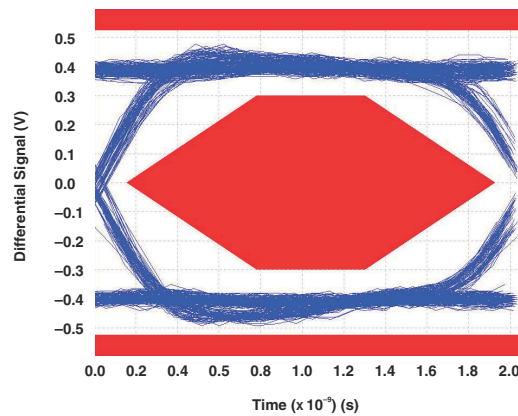


図 8-4. Eye Pattern: 480Mbps USB Signal With Switch NO Path

8.3 Power Supply Recommendations

Make sure the power to the device is supplied through the V_{CC} pin and follows the USB 1.0, 1.1, and 2.0 standards. TI recommends placing a bypass capacitor as close as possible to the supply pin V_{CC} to help smooth out lower frequency noise to provide better load regulation across the frequency spectrum.

8.4 Layout

8.4.1 Layout Guidelines

Place supply bypass capacitors as close to V_{CC} pin as possible. Avoid placing the bypass caps near the D+/D– traces.

Make sure the high-speed D+/D– trace lengths match and are no more than 4 inches, otherwise the eye diagram performance can degrade. A high-speed USB connection is made through a shielded, twisted pair cable with a differential characteristic impedance. In the layout, make sure the impedance of D+ and D– traces match the cable characteristic differential impedance for optimal performance.

Route the high-speed USB signals using a minimum of vias and corners to reduce signal reflections and impedance changes. When a via must be used, increase the clearance size around the via to minimize the capacitance. Each via introduces discontinuities in the transmission line of the signal and increases the chance of picking up interference from the other layers of the board. Be careful when designing test points on twisted pair lines; through-hole pins are not recommended.

When it becomes necessary to turn 90°, use two 45° turns or an arc instead of making a single 90° turn. This reduces reflections on the signal traces by minimizing impedance discontinuities.

Do not route USB traces under or near crystals, oscillators, clock signal generators, switching regulators, mounting holes, magnetic devices or ICs that use or duplicate clock signals.

Avoid stubs on the high-speed USB signals because stubs cause signal reflections. If a stub is unavoidable, keep the stub less than 200mm.

Route all high-speed USB signal traces over continuous planes (V_{CC} or GND), with no interruptions.

Avoid crossing over anti-etch, commonly found with plane splits.

A printed circuit board with at least four layers is recommended because of high frequencies associated with the USB; two signal layers separated by a ground and power layer as shown in [Figure 8-5](#).

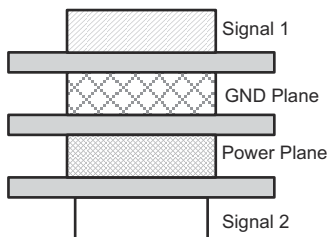


Figure 8-5. Four-Layer Board Stack-Up

Make sure the majority of signal traces run on a single layer, preferably Signal 1. Make sure the GND plane, which is solid with no cuts, is immediately next to this layer. Avoid running signal traces across a split in the ground or power plane. When running across split planes is unavoidable, sufficient decoupling must be used. Minimizing the number of signal vias reduces EMI by reducing inductance at high frequencies. For more information on layout guidelines, see [High Speed Layout Guidelines](#) and [USB 2.0 Board Design and Layout Guidelines](#).

8.4.2 Layout Example

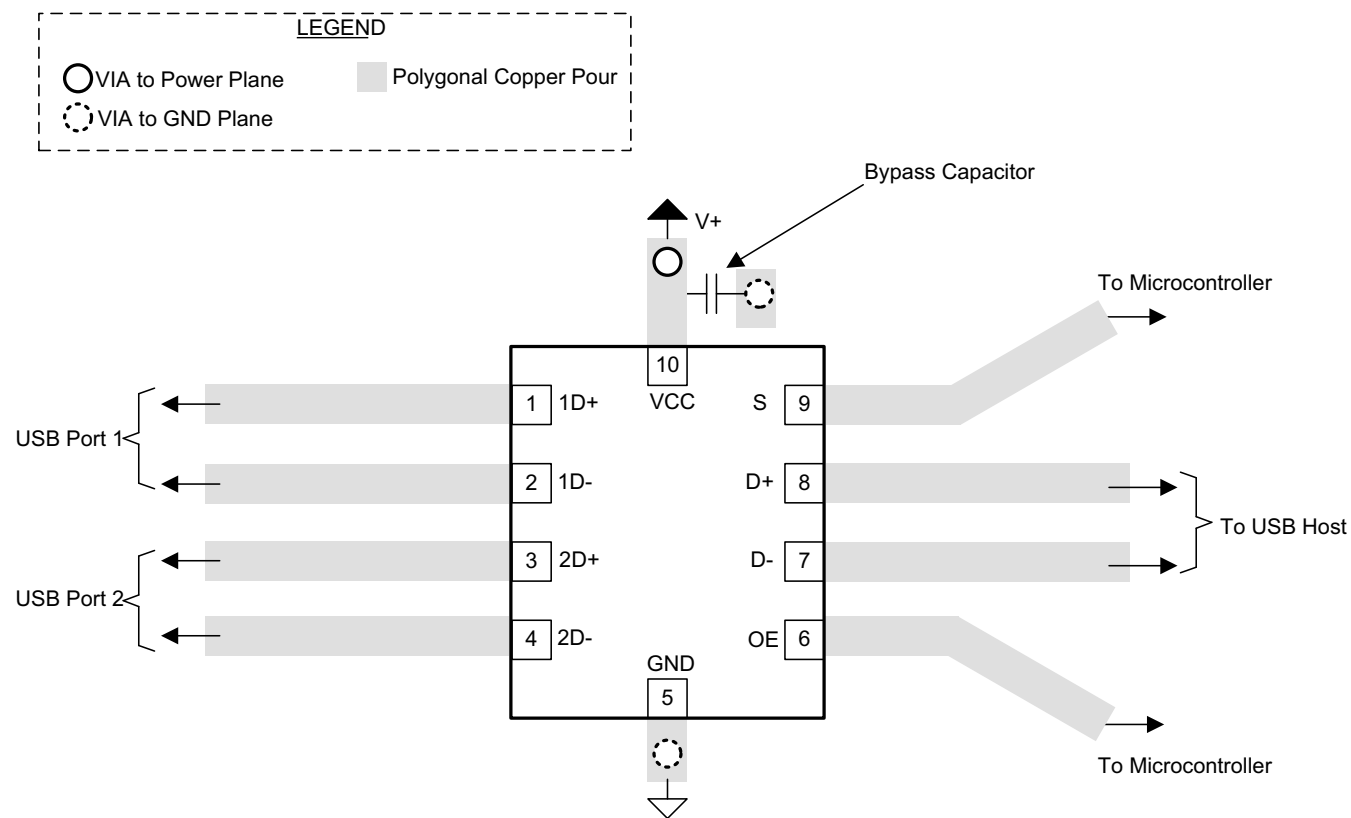


図 8-6. Package Layout Diagram

9 Device and Documentation Support

9.1 Documentation Support

9.1.1 Related Documentation

For related documentation, see the following:

- Texas Instruments, [High Speed Layout Guidelines](#)
- Texas Instruments, [USB 2.0 Board Design and Layout Guidelines](#)
- Texas Instruments, [Implications of Slow or Floating CMOS Inputs application note](#)

9.2 ドキュメントの更新通知を受け取る方法

ドキュメントの更新についての通知を受け取るには、www.tij.co.jp のデバイス製品フォルダを開いてください。[通知] をクリックして登録すると、変更されたすべての製品情報に関するダイジェストを毎週受け取ることができます。変更の詳細については、改訂されたドキュメントに含まれている改訂履歴をご覧ください。

9.3 サポート・リソース

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ESD による破損は、わずかな性能低下からデバイスの完全な故障まで多岐にわたります。精密な IC の場合、パラメータがわずかに変化するだけで公表されている仕様から外れる可能性があるため、破損が発生しやすくなっています。

9.6 用語集

[テキサス・インスツルメンツ用語集](#) この用語集には、用語や略語の一覧および定義が記載されています。

10 Revision History

資料番号末尾の英字は改訂を表しています。その改訂履歴は英語版に準じています。

Changes from Revision L (October 2024) to Revision M (November 2024) Page

- 「概要」セクションと「動的電氣的特性」表に記載されている帯域幅の標準値を次のように変更: 1.1GHz から 1GHz.. 1

Changes from Revision K (July 2024) to Revision L (October 2024) Page

- 特長の項目を次のように変更 $R_{ON} = 6\omega$ (最大値) から $R_{ON} = 6\Omega$ (最大値)..... 1
- 「特長」の箇条書き項目を「 $\delta r_{ON} = 0.2\omega$ (標準値)」から次のように変更 $\Delta r_{ON} = 0.2\Omega$ (標準値)..... 1

Changes from Revision J (January 2019) to Revision K (July 2024)	Page
ドキュメント全体にわたって表、図、相互参照の採番方法を更新.....	1
帯域幅の標準値を次のように変更: 1.1GHz から 1GHz.....	1
Added footnote to the V_{IO} parameter in the <i>Absolute Maximum Ratings</i> table.....	4
Changed CDM test conditions in the <i>ESD Ratings</i> table from: per JEDEC specification JESD22-C101 to: per ANSI/ESDA/JEDEC JS-002.....	4
Changed RSE (UQFN) junction-to-ambient thermal resistance value from: 169.8°C/W to: 204.8°C/W.....	5
Changed RSE (UQFN) junction-to-case (top) thermal resistance value from: 84.7°C/W to: 118.1°C/W.....	5
Changed RSE (UQFN) junction-to-board thermal resistance value from: 94.9°C/W to: 121.5°C/W.....	5
Changed RSE (UQFN) junction-to-top characterization parameter value from: 5.7°C/W to: 13.9°C/W.....	5
Changed RSE (UQFN) junction-to-board characterization parameter value from: 94.9°C/W to: 121.2°C/W.....	5
Changed the V_{IK} value in the <i>Electrical Characteristics</i> table from: –1.8V maximum to: –1.8V minimum.....	5
Changed the <i>Typical Characteristics</i> section.....	7

Changes from Revision I (January 2016) to Revision J (January 2019)	Page
Added CDM value and table notes to the <i>ESD Ratings</i>	4

Changes from Revision H (February 2015) to Revision I (January 2016)	Page
Changed V_{IH} Max from 5.5 to V_{CC} in <i>Recommended Operating Conditions</i> table.....	4

Changes from Revision G (September 2010) to Revision H (February 2015)	Page
「特長」の最初の箇条書き項目を「2.5V および 3.3V の V_{CC} で動作」から「2.3V および 3.6V の V_{CC} で動作」に変更	1
「ピン構成および機能」セクション、「ESD 定格」表、「機能説明」セクション、「デバイスの機能モード」セクション、「アプリケーションと実装」セクション、「電源に関する推奨事項」セクション、「レイアウト」セクション、「デバイスおよびドキュメントのサポート」セクション、「メカニカル、パッケージ、および注文情報」セクションを追加	1
「注文情報」表を削除.....	1

11 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

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PACKAGING INFORMATION

Orderable part number	Status (1)	Material type (2)	Package Pins	Package qty Carrier	RoHS (3)	Lead finish/ Ball material (4)	MSL rating/ Peak reflow (5)	Op temp (°C)	Part marking (6)
SN080104RSER	Active	Production	UQFN (RSE) 10	3000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	(L57, L5H, L5O, L5 R, L5V)
TS3USB221DRCR	Active	Production	VSON (DRC) 10	3000 LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 85	ZWG
TS3USB221DRCR.A	Active	Production	VSON (DRC) 10	3000 LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 85	ZWG
TS3USB221DRCR.B	Active	Production	VSON (DRC) 10	3000 LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 85	ZWG
TS3USB221DRCRG4	Active	Production	VSON (DRC) 10	3000 LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 85	ZWG
TS3USB221RSER	Active	Production	UQFN (RSE) 10	3000 LARGE T&R	Yes	NIPDAU NIPDAU	Level-1-260C-UNLIM	-40 to 85	(L57, L5H, L5O, L5 R, L5V)
TS3USB221RSER.A	Active	Production	UQFN (RSE) 10	3000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	(L57, L5H, L5O, L5 R, L5V)
TS3USB221RSER.B	Active	Production	UQFN (RSE) 10	3000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	(L57, L5H, L5O, L5 R, L5V)
TS3USB221RSERG4	Active	Production	UQFN (RSE) 10	3000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	(L57, L5H, L5O, L5 R, L5V)

⁽¹⁾ **Status:** For more details on status, see our [product life cycle](#).

⁽²⁾ **Material type:** When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

⁽³⁾ **RoHS values:** Yes, No, RoHS Exempt. See the [TI RoHS Statement](#) for additional information and value definition.

⁽⁴⁾ **Lead finish/Ball material:** Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

⁽⁵⁾ **MSL rating/Peak reflow:** The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

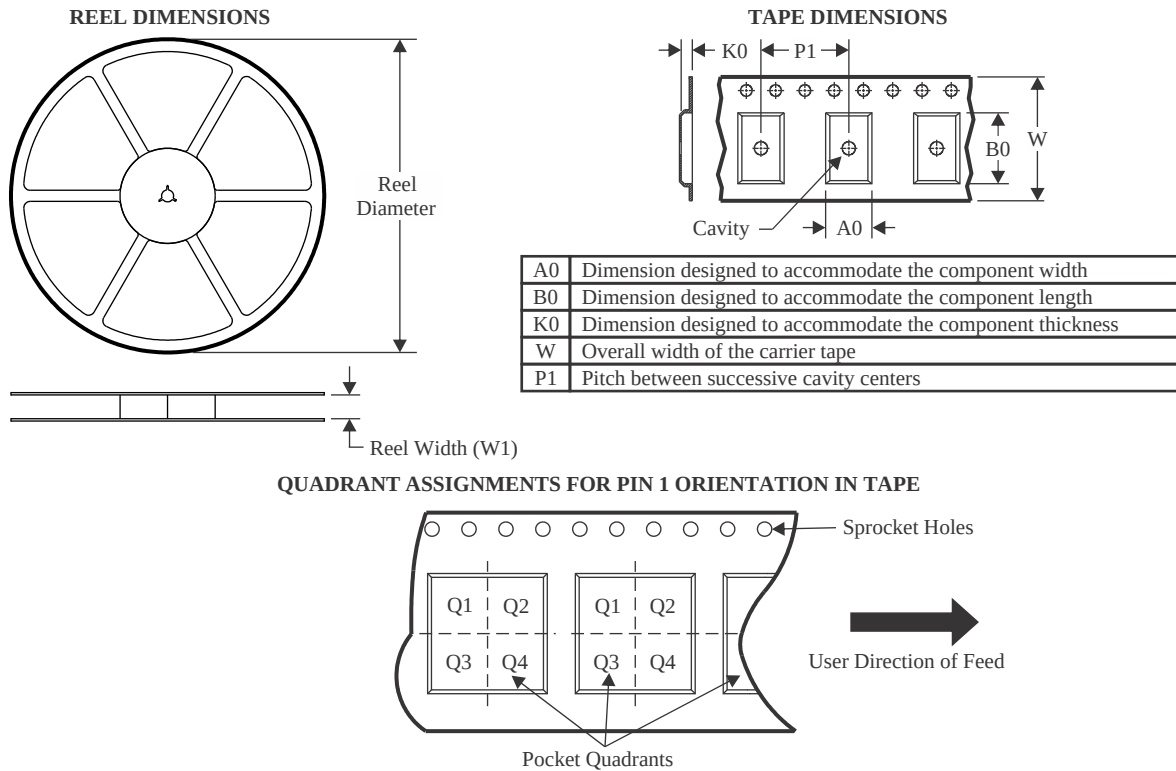
⁽⁶⁾ **Part marking:** There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

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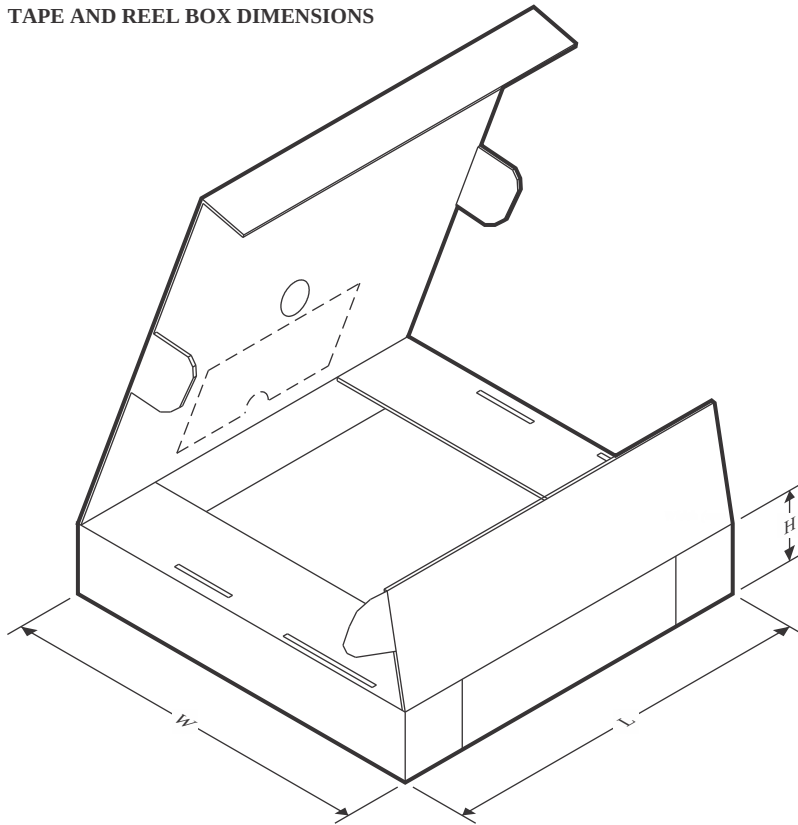
TAPE AND REEL INFORMATION



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
TS3USB221DRCR	VSON	DRC	10	3000	330.0	12.4	3.3	3.3	1.1	8.0	12.0	Q2
TS3USB221RSER	UQFN	RSE	10	3000	180.0	8.4	1.68	2.13	0.76	4.0	8.0	Q1
TS3USB221RSER	UQFN	RSE	10	3000	180.0	9.5	1.7	2.2	0.75	4.0	8.0	Q1

TAPE AND REEL BOX DIMENSIONS



*All dimensions are nominal

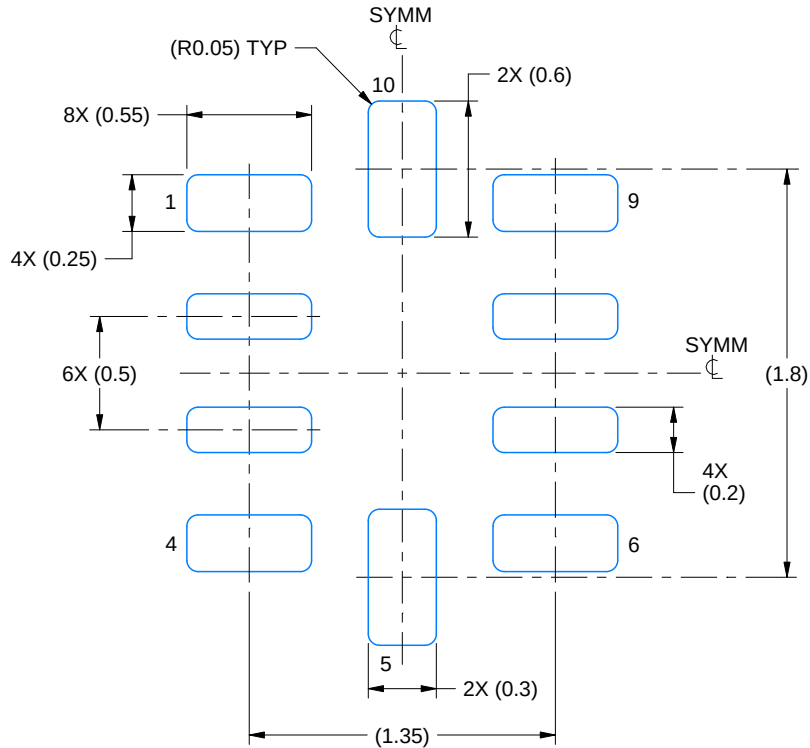
Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
TS3USB221DRCR	VSON	DRC	10	3000	356.0	356.0	35.0
TS3USB221RSER	UQFN	RSE	10	3000	210.0	185.0	35.0
TS3USB221RSER	UQFN	RSE	10	3000	189.0	185.0	36.0

EXAMPLE BOARD LAYOUT

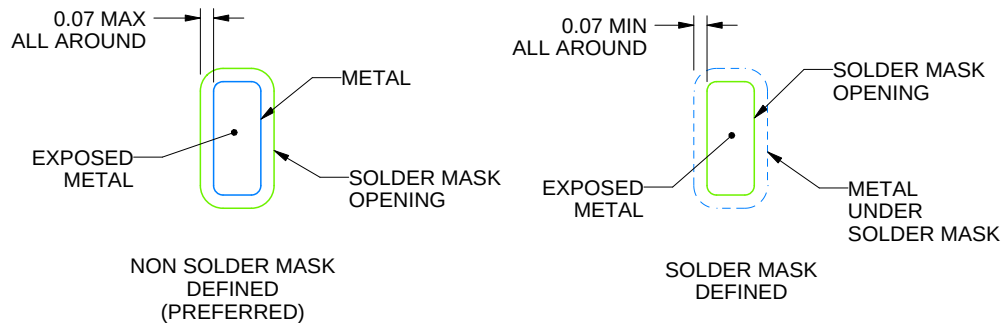
RSE0010A

UQFN - 0.6 mm max height

PLASTIC QUAD FLATPACK - NO LEAD



LAND PATTERN EXAMPLE
EXPOSED METAL SHOWN
SCALE:30X



SOLDER MASK DETAILS
NOT TO SCALE

4220307/A 03/2020

NOTES: (continued)

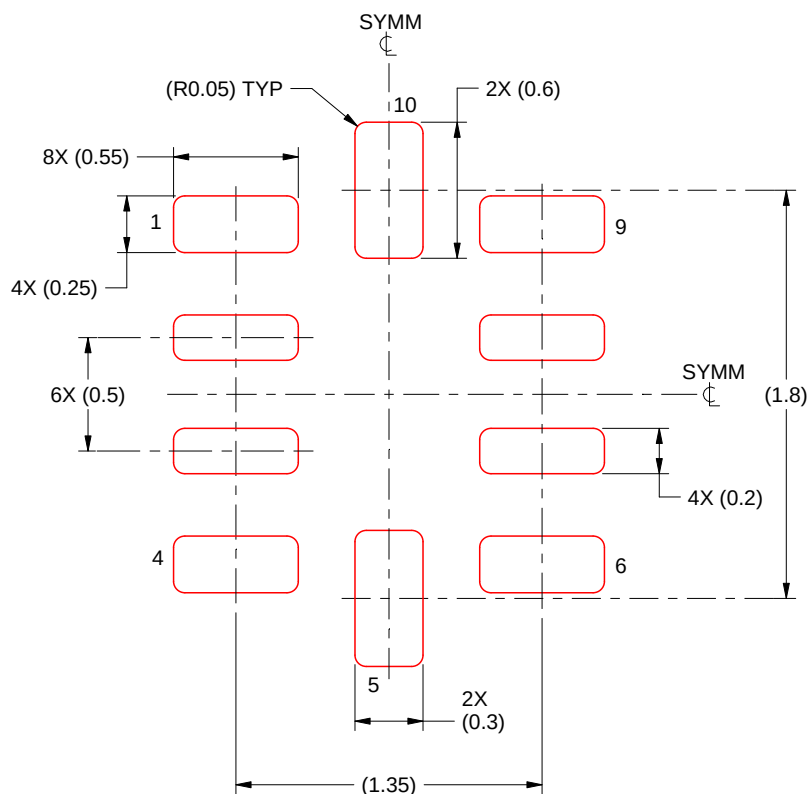
3. For more information, see Texas Instruments literature number SLUA271 (www.ti.com/lit/sluea271).

EXAMPLE STENCIL DESIGN

RSE0010A

UQFN - 0.6 mm max height

PLASTIC QUAD FLATPACK - NO LEAD



SOLDER PASTE EXAMPLE
BASED ON 0.1 mm THICKNESS
SCALE: 30X

4220307/A 03/2020

NOTES: (continued)

5. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.

GENERIC PACKAGE VIEW

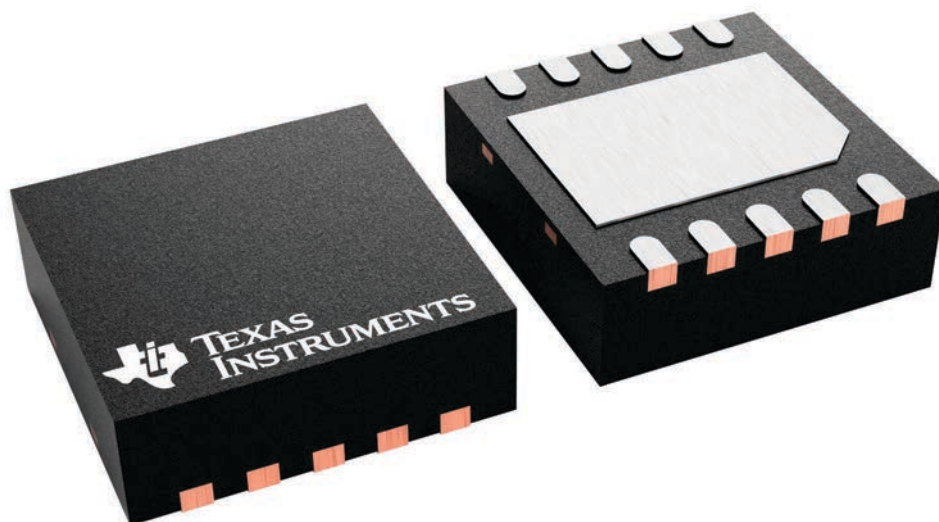
DRC 10

VSON - 1 mm max height

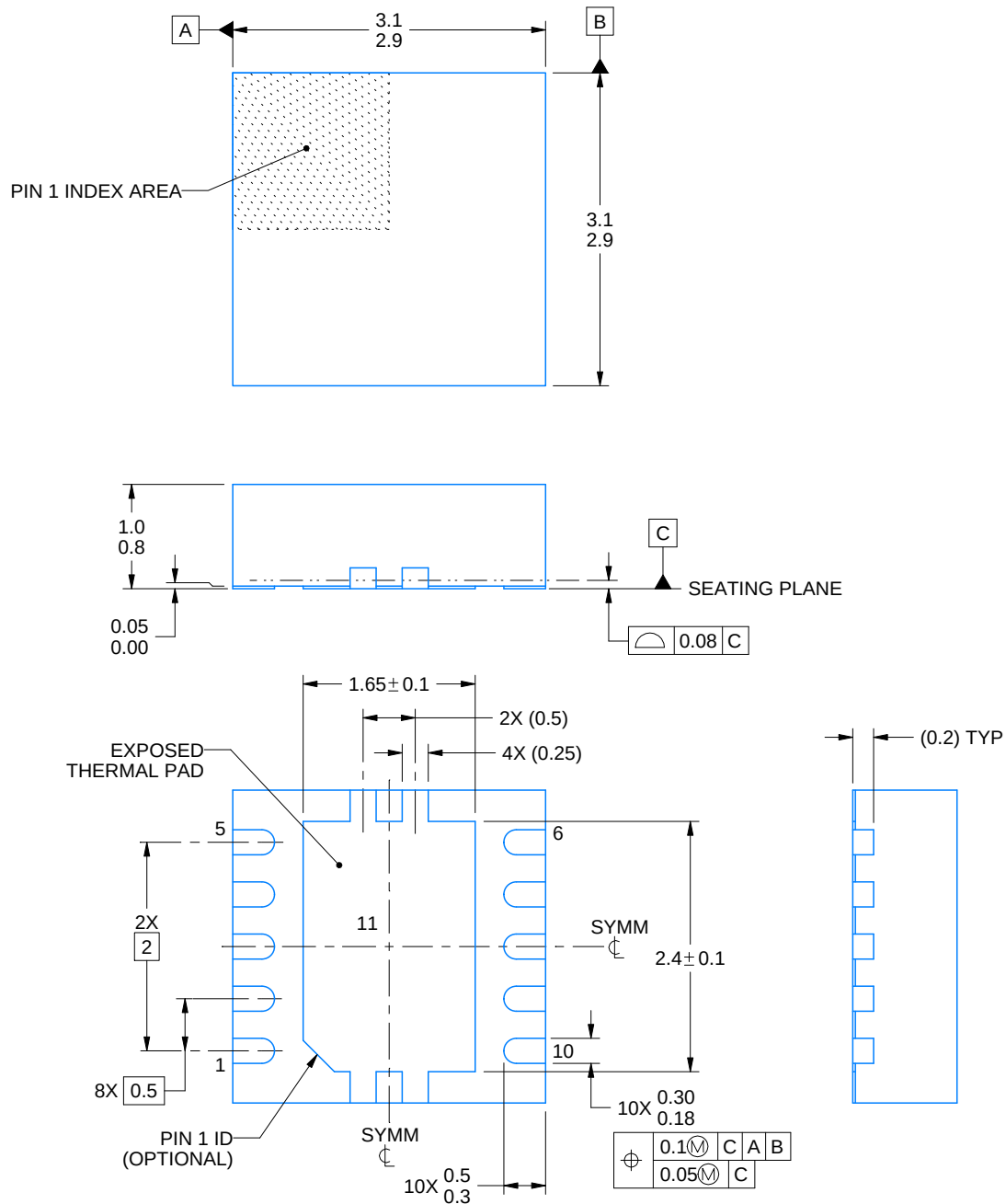
3 x 3, 0.5 mm pitch

PLASTIC SMALL OUTLINE - NO LEAD

This image is a representation of the package family, actual package may vary.
Refer to the product data sheet for package details.



4226193/A



4218878/B 07/2018

NOTES:

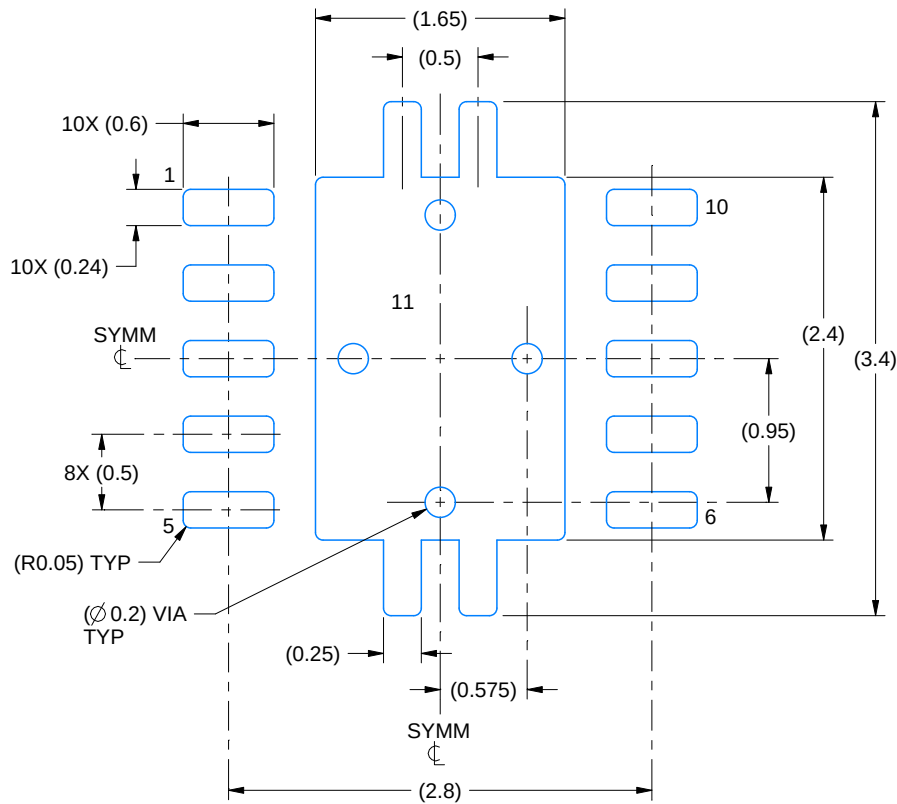
1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. The package thermal pad must be soldered to the printed circuit board for optimal thermal and mechanical performance.

EXAMPLE BOARD LAYOUT

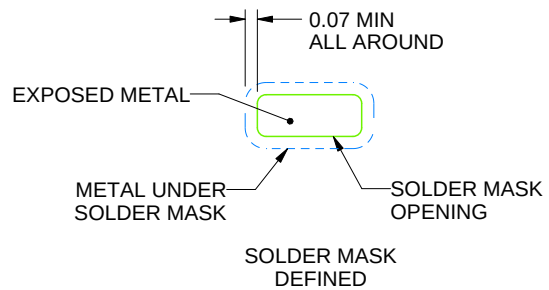
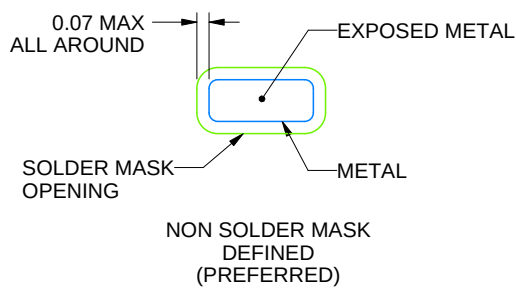
DRC0010J

VSON - 1 mm max height

PLASTIC SMALL OUTLINE - NO LEAD



LAND PATTERN EXAMPLE
EXPOSED METAL SHOWN
SCALE:20X



SOLDER MASK DETAILS

4218878/B 07/2018

NOTES: (continued)

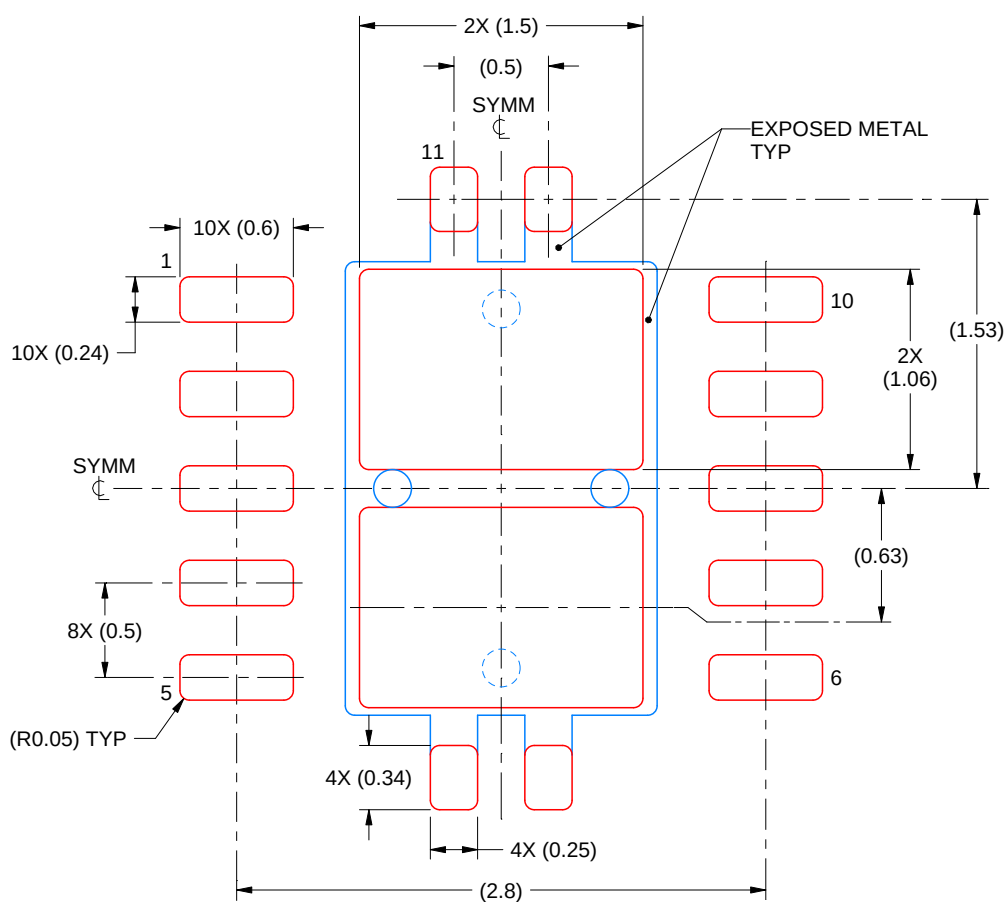
4. This package is designed to be soldered to a thermal pad on the board. For more information, see Texas Instruments literature number SLUA271 (www.ti.com/lit/sluea271).
5. Vias are optional depending on application, refer to device data sheet. If any vias are implemented, refer to their locations shown on this view. It is recommended that vias under paste be filled, plugged or tented.

EXAMPLE STENCIL DESIGN

DRC0010J

VSON - 1 mm max height

PLASTIC SMALL OUTLINE - NO LEAD



SOLDER PASTE EXAMPLE
BASED ON 0.125 mm THICK STENCIL

EXPOSED PAD 11:
80% PRINTED SOLDER COVERAGE BY AREA
SCALE:25X

4218878/B 07/2018

NOTES: (continued)

6. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.

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郵送先住所：Texas Instruments, Post Office Box 655303, Dallas, Texas 75265
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